

Supporting Information

**Contact line dynamics modulated by electrode roughness
determines bubble detachment size**

Weikang Yang^{a,*}, Dongxu Gu^b, Xin Liu^a, Qiangmin Luo^a

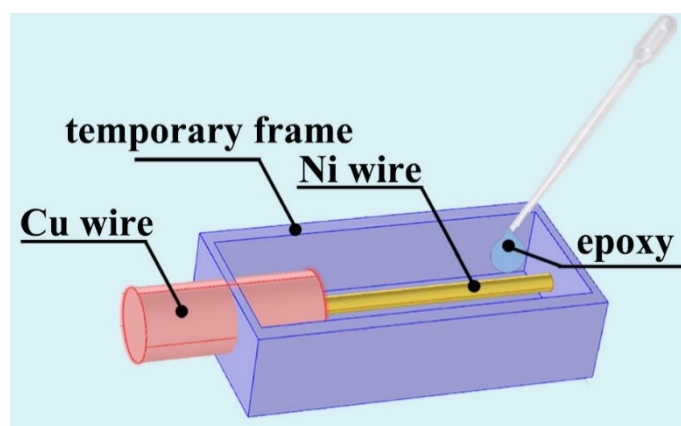
^a School of Chemistry and Chemical Engineering, Chongqing University,
Chongqing 400044, PR China.

^b Institute of Intelligent Innovation, Henan Academy of Sciences, Zhengzhou,
Henan, 451162, P. R. China.

*Corresponding author. E-mail: wkyang@stu.cqu.edu.cn; Phone: +86 18725737346.

13 1. Electrode Preparation

14 The nickel ($\text{Ø}500\text{ }\mu\text{m}$) wire-welded copper leads were fixed onto a pre-
15 assembled square frame (Fig. S1). Epoxy resin was prepared by mixing component A
16 and B at a mass ratio of 2:1. Vigorous stirring introduced numerous microbubbles,
17 resulting in an opaque, milky-white mixture. To eliminate entrapped bubbles, the
18 epoxy was centrifuged until achieving optical clarity and high fluidity. After 30
19 minutes of static curing at ambient temperature (28°C), the resin's viscosity increased
20 moderately, at which point it was poured into the frame to encapsulate the electrode.
21 Additional epoxy layers could be applied within 1 hour to ensure complete coverage
22 of both nickel wire and copper leads. The assembly was then cured at room
23 temperature for 12 hours before frame removal. Finally, polished edges were created
24 on the cured epoxy block to facilitate subsequent experimental observations.



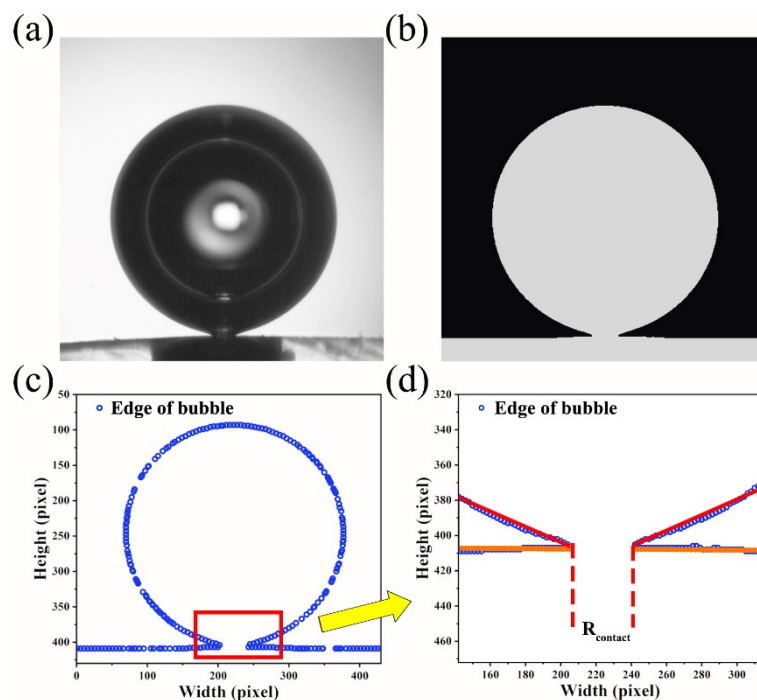
25
26 **Fig. S1.** Schematic of the electrode package.

27 The subsequent Ni electrodes working face was directly polished using
28 sandpaper (wuxi-1200, wuxi-800 and wuxi-400) to prepare three representative Ni
29 electrodes with varying surface roughness, which were utilized as working electrodes.
30 While our embedded electrode design enables precise observation of bubble dynamics,

31 it inherently creates lateral inhomogeneity in electrochemical rates. As noted in recent
32 studies^{1,2}, such inhomogeneity may induce density-driven convection. Although this
33 effect does not alter our primary conclusions on contact line dynamics, future work
34 could explicitly quantify its influence through computational fluid dynamics
35 simulations.

36 **2. Image Analysis**

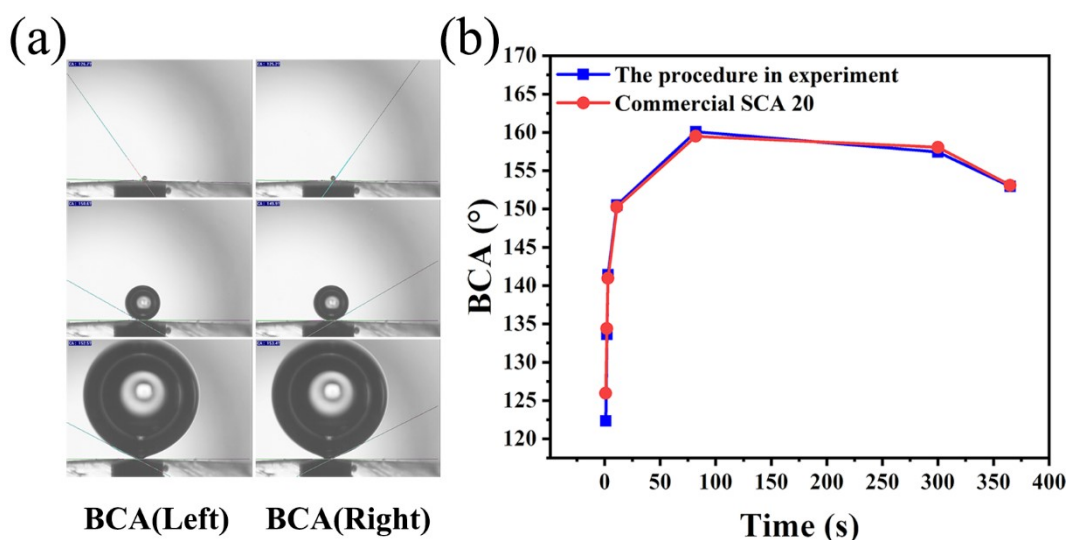
37 The image analysis program was developed based on the image processing
38 module of MATLAB (R 2022b). Firstly, the background was subtracted, and then the
39 contrast and brightness were adjusted for further binarization. Fig. S2a and S2b
40 present the bubble images after contrast enhancement and binarization processing,
41 respectively. To quantify the contact line dynamics, edge coordinates were extracted
42 from the processed images using computational algorithms, as demonstrated by the
43 scatter plot in Fig. S2c. The bottom radius and contact angle of the bubble were
44 subsequently determined through statistical analysis of the spatial distribution
45 characteristics of these edge coordinate points.



46

47 **Fig. S2.** (a) the original image with contrast enhancement; (b) the binarized image; (c) Scattered
48 data at the edges; (d) Scatter points used to fit the baseline and tangents.

49 To verify the accuracy of our custom-developed algorithm, we compared its
50 contact angle calculations with those obtained from commercial contact angle
51 measurement software (SCA20) at multiple time points. As illustrated in Fig. S3a,
52 representative images from the commercial software's fitting process are displayed
53 (three typical examples shown), while Fig. S3b presents the complete dataset
54 comparison between both methods. The custom algorithm demonstrated consistent
55 reliability throughout the measurement period, with a maximum deviation of less than
56 2° compared to the commercial software. Notably, the automated processing
57 capability of our custom program addressed the critical limitation of the commercial
58 software, which could only perform manual frame-by-frame analysis - a method
59 unsuitable for our high-throughput experimental requirements.

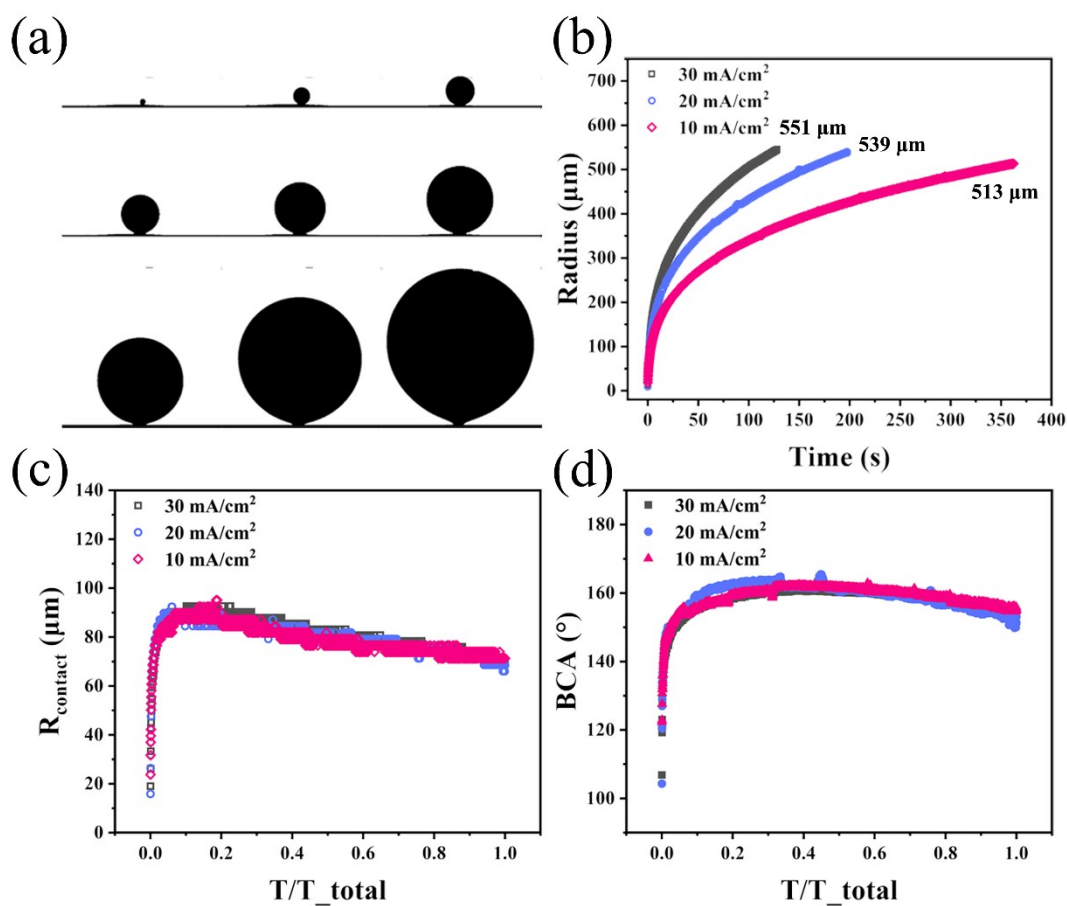


60 **Fig. S3.** (a) Commercial software SCA20 to measure the contact angle; (b) Comparison of contact
61 angles obtained by the program and results obtained by commercial software.
62

63 3. Contact line dynamics at different current densities

64 To investigate potential current density effects on hydrogen bubble adhesion
65 dynamics, we first examined bubble growth patterns on the smoothest Ni electrode
66 surface (M1). Fig. S4a presents processed images of the bubble growth process,
67 clearly showing neck formation during expansion. The radius-time curves in Fig. S4b
68 reveal that as the current density increases, the bubble detachment size grows from
69 513 μm to 551 μm , corresponding to an approximately 24% increase in additional
70 buoyancy force. This suggests that the current density generates an additional
71 downward force. As demonstrated by Park et al.³, the ion concentration gradient
72 generated near the electrode induces solutal Marangoni flow, which exerts an
73 additional downward force on the bubble (in sulfuric acid electrolyte). The elevated
74 current density leads to increased ion concentration gradients, which may explain the
75 slightly larger detachment sizes observed in our experiments. Notably, higher current

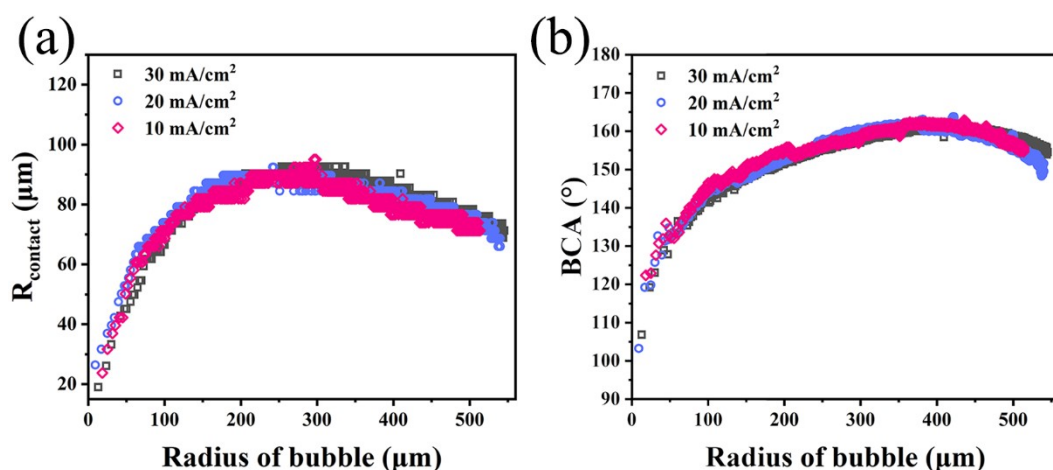
76 densities accelerated bubble growth rates due to enhanced hydrogen generation,
 77 leading to greater molecular hydrogen concentration gradients and interfacial mass
 78 transfer fluxes at the electrode surface. Contact line dynamics (Fig. S4c) exhibited
 79 universal characteristics regardless of current density: rapid expansion to a maximum
 80 radius of 90 μm , followed by gradual contraction to 70 μm at detachment. Similarly,
 81 contact angles (Fig. S4d) demonstrated consistent evolution - rapid increase to 160°,
 82 stabilization, then decline to $\sim 150^\circ$ at detachment.



83
 84 **Fig. S4.** (a) Commercial software SCA20 to measure the contact angle; (b) Comparison of contact
 85 angles obtained by the program and results obtained by commercial software.

86 Fig. S5 presents the bubble contact line parameters normalized by bubble size to
 87 eliminate temporal effects. The size-normalized analysis reveals remarkable

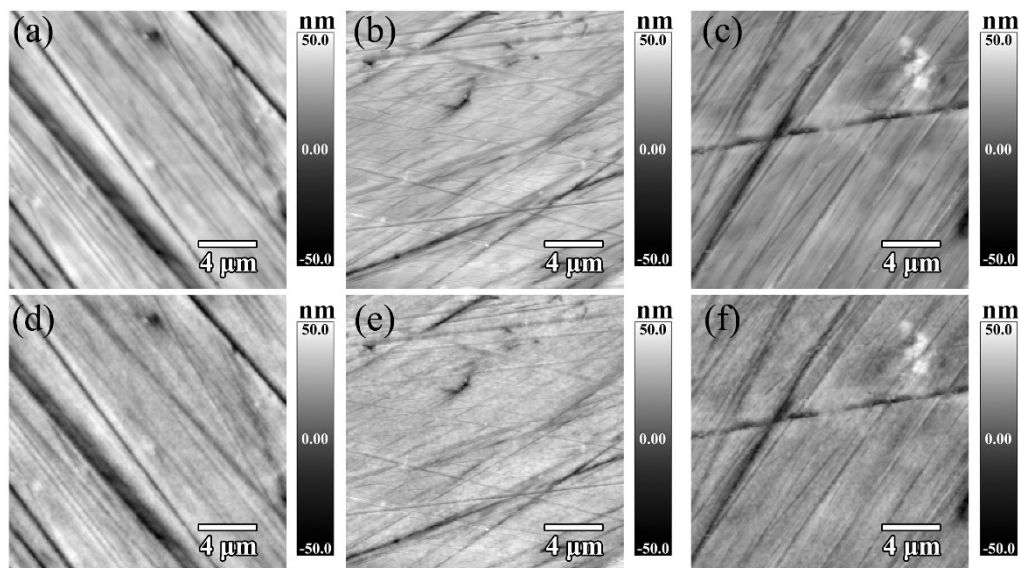
88 consistency in contact line behavior across different current densities. As shown in
 89 Fig. S5a, the contact radius initially increases with bubble growth, reaching a
 90 maximum value of 94 μm at a bubble size of 253 μm , after which further bubble
 91 expansion leads to contact line contraction. The dynamic contact angle evolution (Fig.
 92 S5b) similarly demonstrates current-density-independent characteristics, beginning to
 93 decrease when the bubble reaches 377 μm in size. These findings conclusively
 94 demonstrate that the contact line evolution on a given electrode surface is governed
 95 by surface topography and the resultant force balance, rather than being influenced by
 96 current density variations.



98 **Fig. S5.** Under different current densities: (a) Relationship between contact radius and bubble size;
 99 (b) Relationship between dynamic contact Angle and bubble size.

100 Fig S6 presents the Ni electrode surface morphology before and after HER using
 101 quasi-in situ AFM measurements during 10 min of electrolysis at 20 mA/cm²,
 102 revealing only marginal roughness increases (M1: 5.64→5.69 nm; M2: 8.73→8.97
 103 nm; M3: 13.88→14.32 nm) that confirm negligible structural modifications, while the
 104 bubble behavior appears dominated by initial surface roughness rather than these

105 minimal HER-induced changes due to the orders-of-magnitude larger bubble
106 dimensions compared to roughness variations.



107
108 **Fig. S6.** Two-dimensional morphology of nickel electrode before HER: (a) M1, (b) M2, (c) M3;
109 Two-dimensional morphology of nickel electrode after HER: (d) M1, (e) M2, (f) M3.

111 References

- 112 [1] H. M. Rodriguez, M. Martyniuk, K. S. Iyer and S. Ciampi, *J. Am. Chem. Soc.* 2024, **146**,
113 10299-10311.
114 [2] V. Sahore, A. Kreidermacher, F. Z. Khan and I. Fritsch, *J. Electrochem. Soc.* 2016, **163**,
115 H3135.
116 [3] S. Park, L. Liu, Ç. Demirkır, O. Heijden, D. Lohse, D. Krug and M. T. M. Koper, *Nat. Chem.*,
117 2023, **15**, 1532-1540.